

## AMENDMENTS TO THE CLAIMS

This listing of claims will replace all prior versions, and listings, of the claims in the present application.

1. (Currently amended) A device having a self-scanned photodiode array wherein charge from individual pixels is switched from each pixel sequentially onto at least one output video line after a predetermined exposure time ( $t_0$ ) comprising:

at least one light source;

at least one sample cell having means for receiving light from said at least one light source;

a photo-diode array having pixels for collecting light transmitted through said at least one sample cell, wherein the intensity of said light may vary across the spatial extent of the array;

means for reading said pixels;

means for skipping the reading of selected pixels for one or more additional exposure times  $t_0$  allowing said selected pixels to be exposed for specified integer multiples (M) of said predetermined exposure time  $t_0$ , thereby allowing said selected pixels receiving less light to accumulate additional charge before being read out and thereby reducing the number of read cycles and improving the signal-to-noise ratio.

2. (Original) The self-scanned photodiode array of claim 1 wherein different pixels are exposed for the same or different integer multiples (M) of said predetermined exposure time.

3. (Currently amended) The self-scanned photodiode array of claim 1 in which said predetermined exposure time  $t_0$  does not exceed saturation of the pixel or pixels accumulating charge at a highest rate within a predetermined range of pixels.

4. (Original) The self-scanned photodiode array of claim 1 wherein specified integer multiples M are chosen such that each pixel signal, within a predetermined range of pixels approaches but does not exceed saturation.

5. (Original) The self-scanned photodiode array of claim 1 wherein said exposure time of individual pixels,  $Mt_0$ , does not cause saturation of pixels from which charge is measured.

6. (Currently amended) The self-scanned photodiode array of claim 1 wherein said exposure time of each pixel, is an integer multiple M of said predetermined exposure time  $t_0$ , ~~which does not include the integer 1 wherein the lowest value of M is greater than one.~~

7. (Currently amended) The self-scanned photodiode array of claim 1 wherein [[said]] a sample time is defined as a time taken for one or more complete measurements of the full or selected portion of the photodiode array, said individual pixel exposure times  $Mt_0$  being submultiples of said sample time.

8. (Original) The self-scanned photodiode array of claim 1 wherein said predetermined exposure time  $t_0$  is established when said photo-diode array receives said light according to a reference condition.

9. (Original) The self-scanned photodiode array of claim 3 wherein the predetermined range of pixels includes the full array.

10. (Original) The self-scanned photodiode array of claim 4 wherein the predetermined range of pixels includes the full array.
11. (Original) The self-scanned photodiode array of claim 1 wherein the value recorded when a pixel read is skipped is set to zero to avoid the addition of unnecessary read noise.
12. (Currently amended) A method of improving signal to noise ratio of measurements made using a self-scanned photodiode array to detect light in the ultraviolet, visible and infrared portions of a light spectrum comprising the steps of:
  - exposing pixels of said photodiode array to light received from a reference condition and measuring the spectrum of a short exposure time causing no saturation of said pixels;
  - measuring a dark spectrum of said pixels with shutter closed using said short exposure time;
  - calculating a dark corrected reference signal from each pixel;
  - calculating an exposure time for each pixel such that its accumulated charge would reach a predetermined level, close to but below saturation;
  - establishing a predetermined exposure time  $t_0$ , short enough that no pixel [[is]] in a specified range of interest will saturate;
  - assigning integers M such that individual pixels are exposed for integer multiples of the predetermined exposure time  $Mt_0$ , such that after time  $Mt_0$  said individual pixels have accumulated charge close to but not exceeding saturation;

re-measuring dark spectrum with shutter closed using exposure pattern determined by integers;

re-measuring reference spectrum using exposure pattern determined by integers, thereby creating a dark-corrected reference spectrum;

Measuring sample spectra using the same exposure pattern determined by integers and creating dark corrected sample spectra;

combining reference and sample spectra to determine absorption characteristics of sample and thereby identify and quantitate same with improved signal-to-noise ratio.

13. (New) A self-scanned photodiode array wherein charge from individual pixels is switched from each pixel sequentially onto at least one output video line after a predetermined exposure time ( $t_0$ ) comprising:

an array of photodiode pixels for collecting light, wherein the intensity of said light may vary across the spatial extent of the array;

means for reading said pixels;

means for skipping the reading of selected pixels for one or more additional exposure times  $t_0$  allowing said selected pixels to be exposed for specified integer multiples (M) of said predetermined exposure time  $t_0$ , thereby allowing said selected pixels receiving less light to accumulate additional charge before being read out and thereby reducing the number of read cycles and improving the signal-to-noise ratio of the measured light.